



Total or partial reproduction of this document without permission of the Laboratory is not allowed. BTF Testing Lab (Shenzhen) Co., Ltd. F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Page 74 of 94







5.2 CSE

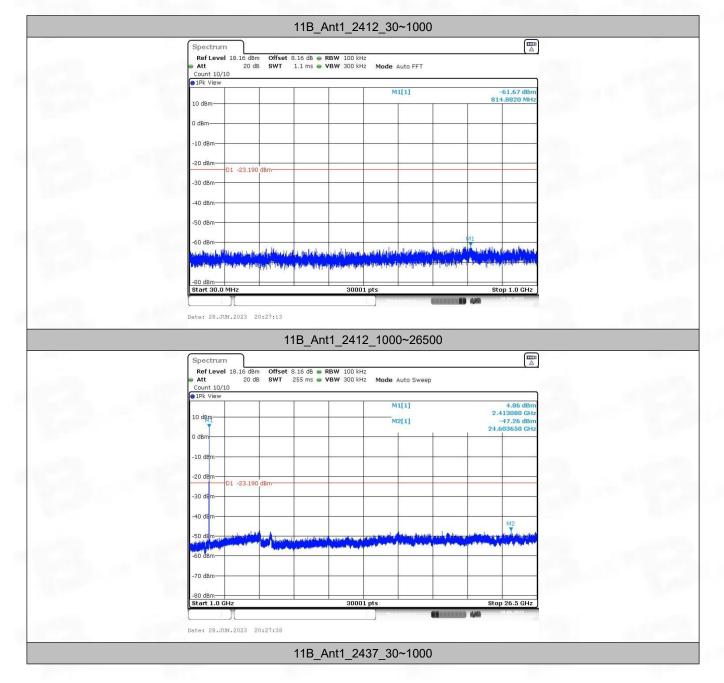
5.2.1 Test Result

			FreqRange RefLevel Result Limit				
TestMode	Antenna	Frequency[MHz]	[Mhz]	[dBm]	[dBm]	[dBm]	Verdic
11B	Ant1	2412	30~1000	6.81	-61.67	 ≤-23.19	PASS
			1000~26500	6.81	-47.26	≤-23.19	PASS
		2437	30~1000	6.75	-60.72	≤-23.25	PASS
			1000~26500	6.75	-44.69	≤-23.25	PAS
		2462	30~1000	6.49	-61.31	≤-23.51	PAS
			1000~26500	6.49	-45.24	≤-23.51	PAS
11G	Ant1	2412	30~1000	1.53	-61.14	≤-28.47	PAS
			1000~26500	1.53	-46.8	≤-28.47	PAS
		2437	30~1000	1.93	-42.43	≤-28.07	PAS
			1000~26500	1.93	-47.57	≤-28.07	PAS
		2462	30~1000	2.27	-60.45	≤-27.73	PAS
			1000~26500	2.27	-46.73	≤-27.73	PAS
11N20SISO	Ant1	2412	30~1000	2.07	-61.05	≤-27.93	PAS
			1000~26500	2.07	-46.95	≤-27.93	PAS
		2437	30~1000	2.51	-60.23	≤-27.49	PAS
			1000~26500	2.51	-47.66	≤-27.49	PAS
		2462	30~1000	2.21	-61.14	≤-27.79	PAS
			1000~26500	2.21	-47.48	≤-27.79	PAS
11N40SISO	Ant1	2422	30~1000	-0.79	-60.85	≤-30.79	PAS
			1000~26500	-0.79	-46	≤-30.79	PAS
		2437	30~1000	-0.28	-60.76	≤-30.28	PAS
			1000~26500	-0.28	-47.39	≤-30.28	PAS
		2452	30~1000	0.16	-60.97	≤-29.84	PAS
			1000~26500	0.16	-47.28	≤-29.84	PAS

Total or partial reproduction of this document without permission of the Laboratory is not allowed.Page 76 of 9BTF Testing Lab (Shenzhen) Co., Ltd.F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

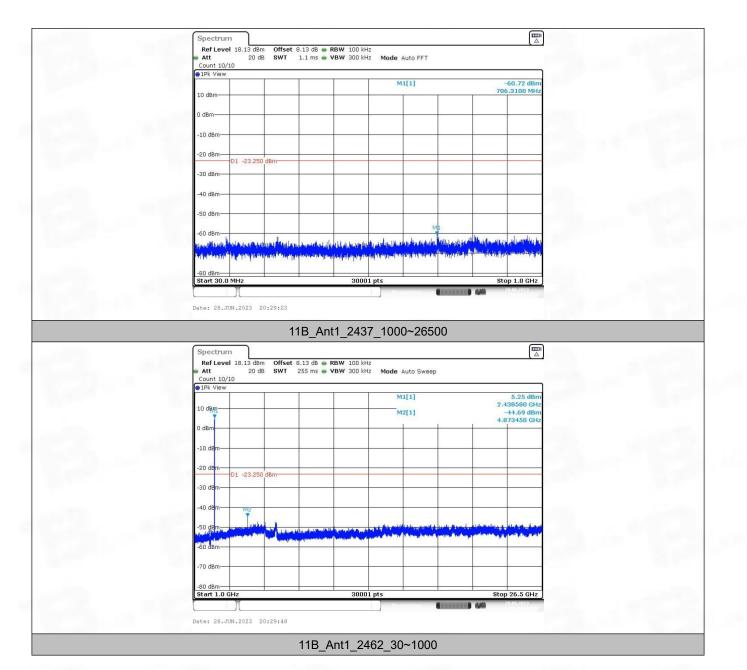


5.2.2 Test Graph



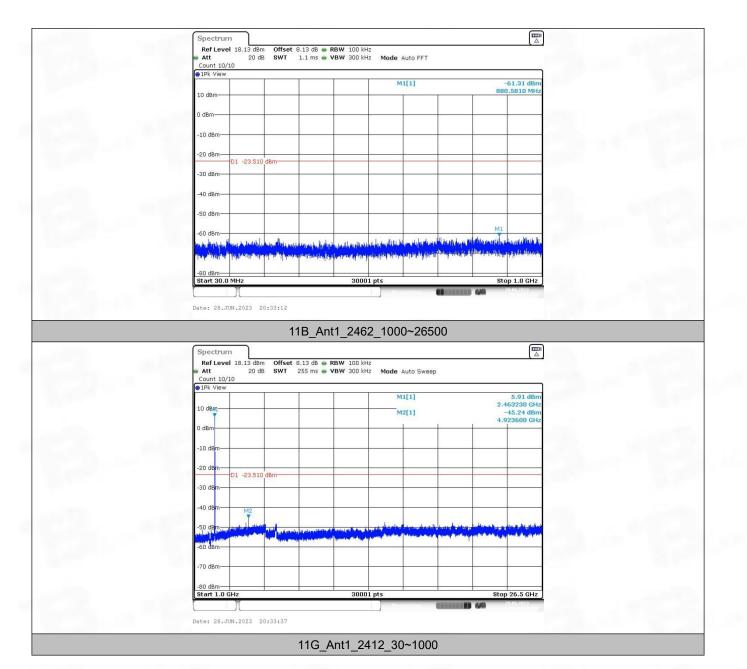
Total or partial reproduction of this document without permission of the Laboratory is not allowed. BTF Testing Lab (Shenzhen) Co., Ltd. Page 77 of 94





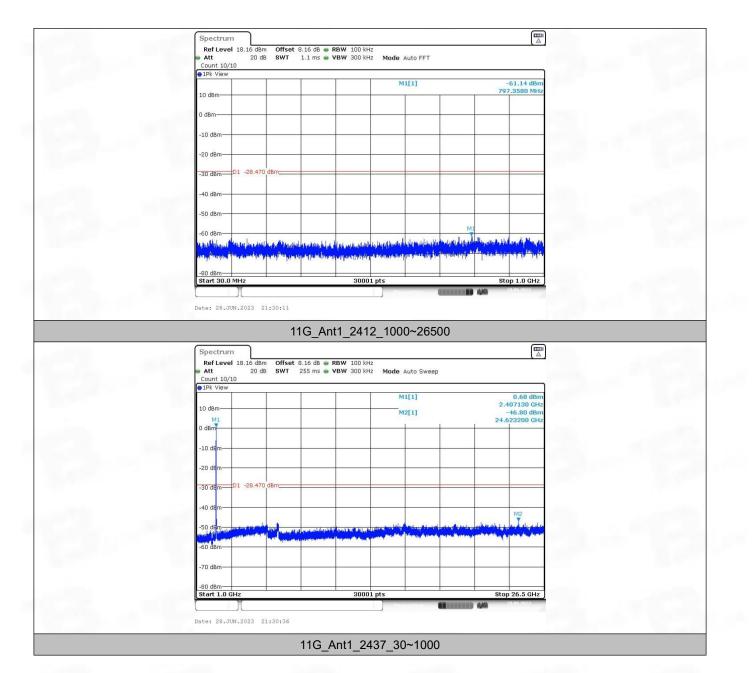
Page 78 of 94





Page 79 of 94

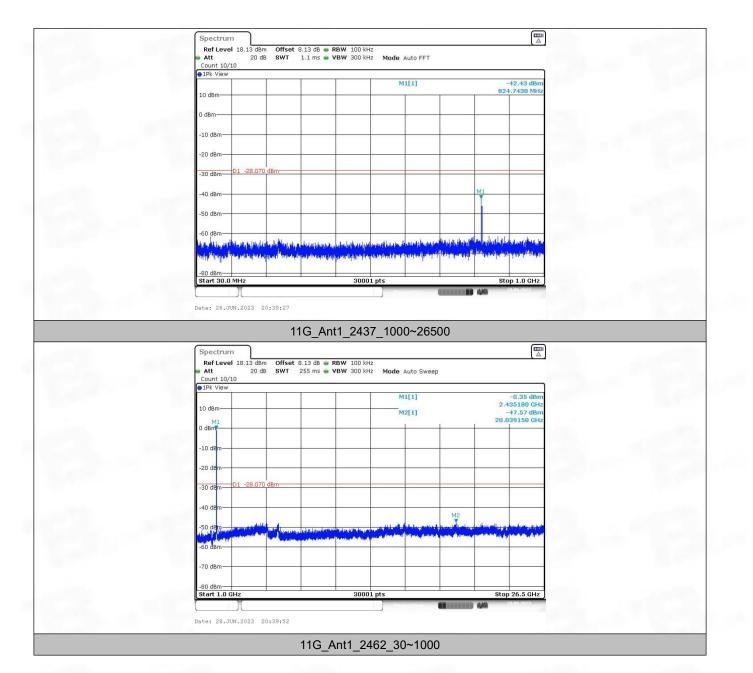




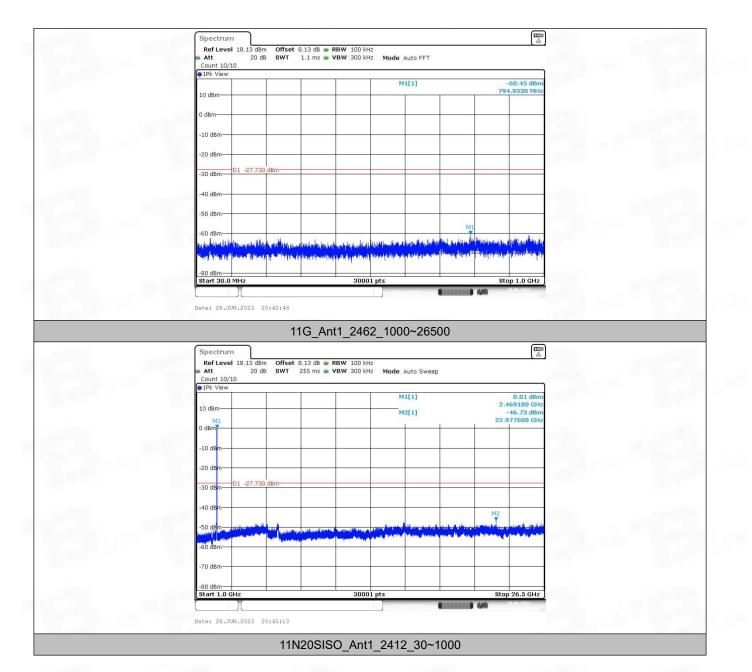
Total or partial reproduction of this document without permission of the Laboratory is not allowed. BTF Testing Lab (Shenzhen) Co., Ltd. F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Page 80 of 94

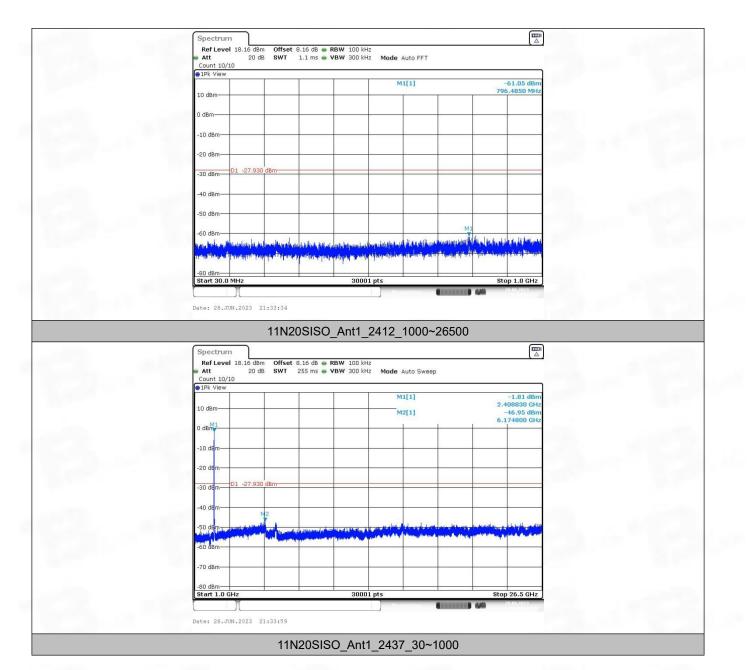






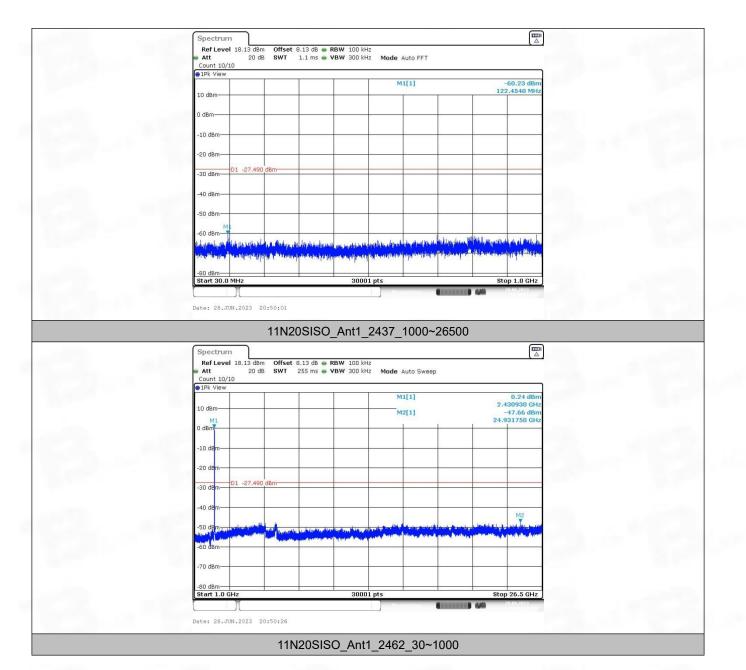






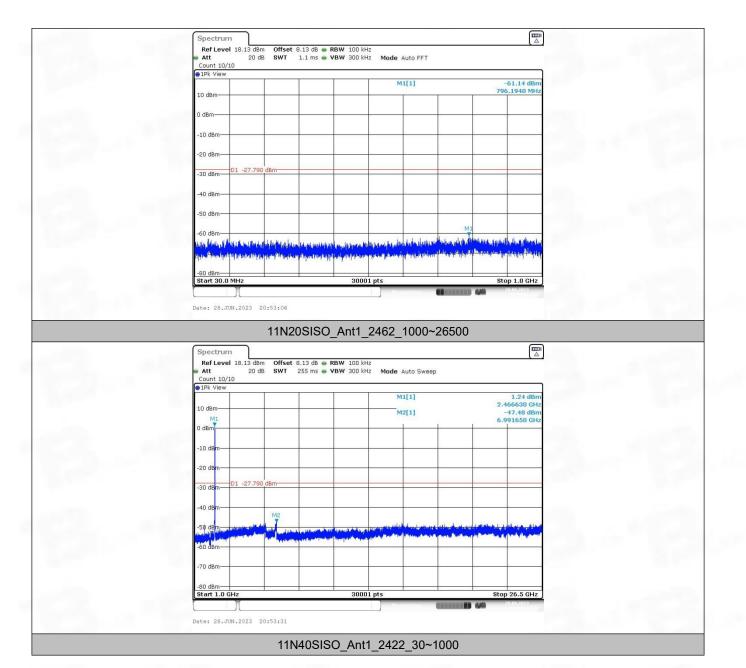
Page 83 of 94





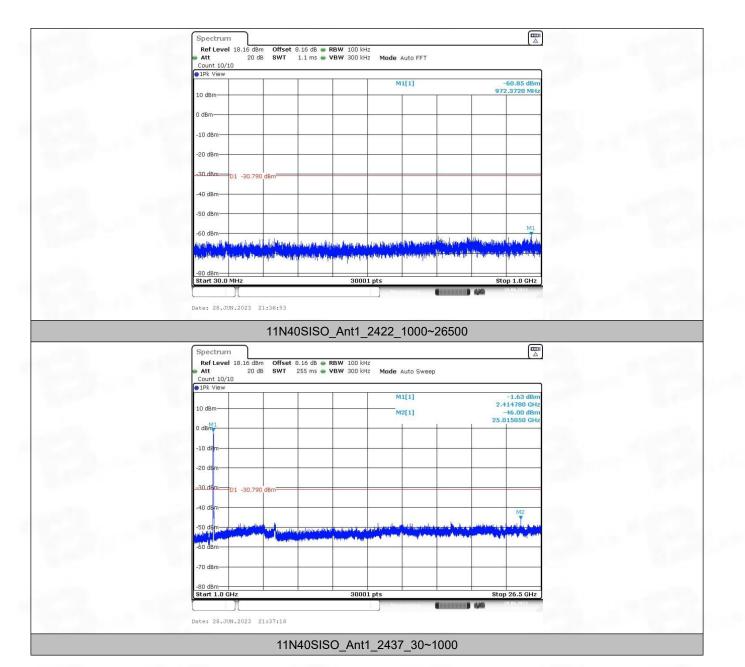
Page 84 of 94





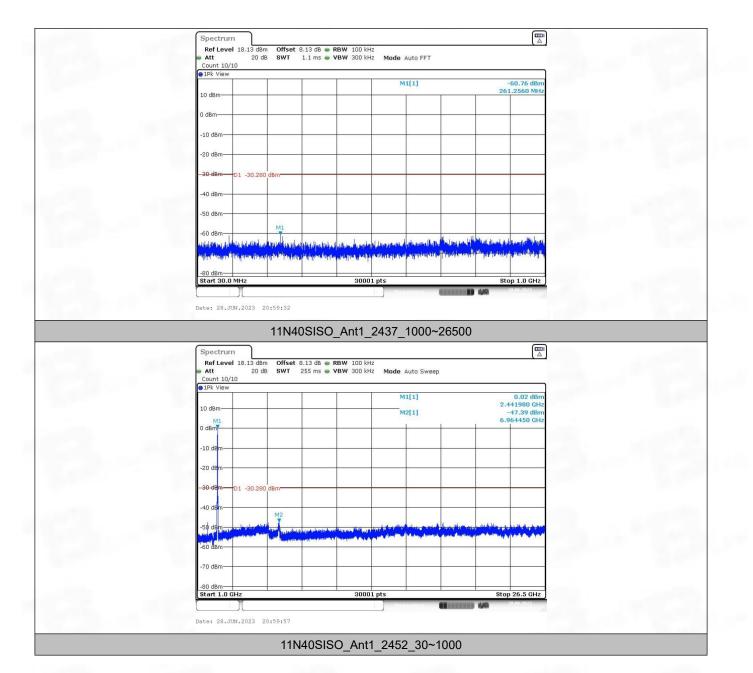
Page 85 of 94





Page 86 of 94

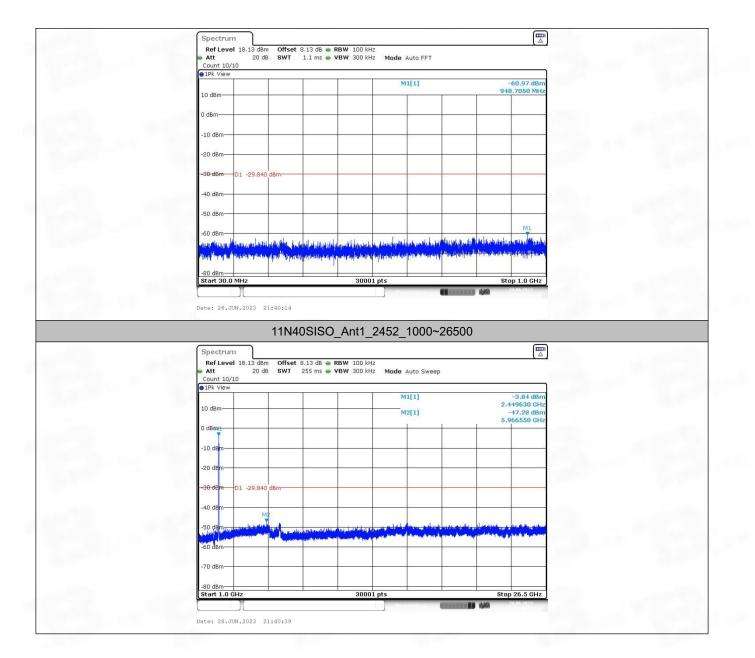




Page 87 of 94



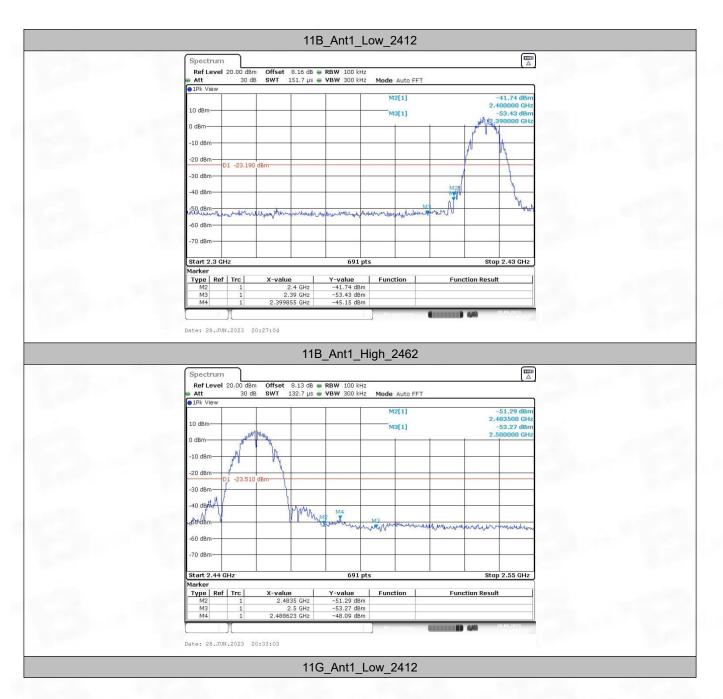
Test Report Number: BTF230710R00304



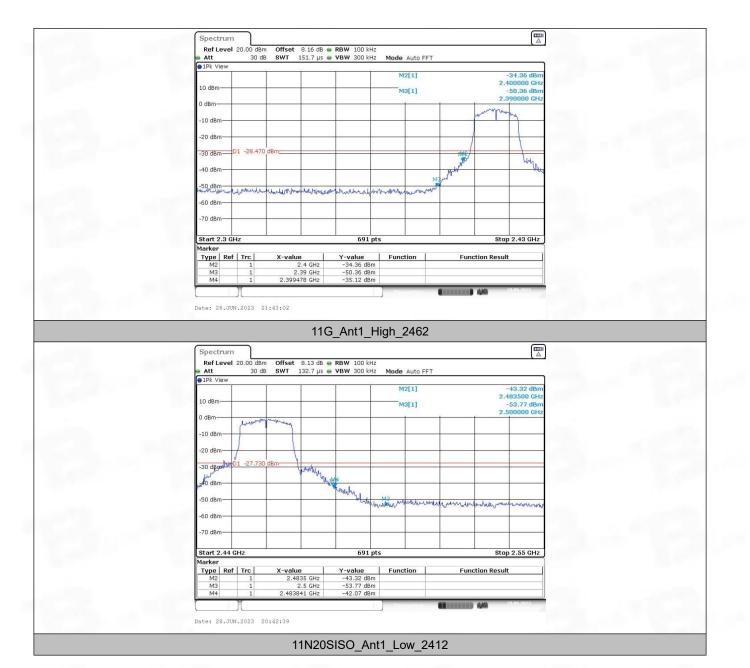
Total or partial reproduction of this document without permission of the Laboratory is not allowed. BTF Testing Lab (Shenzhen) Co., Ltd. F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Page 88 of 94



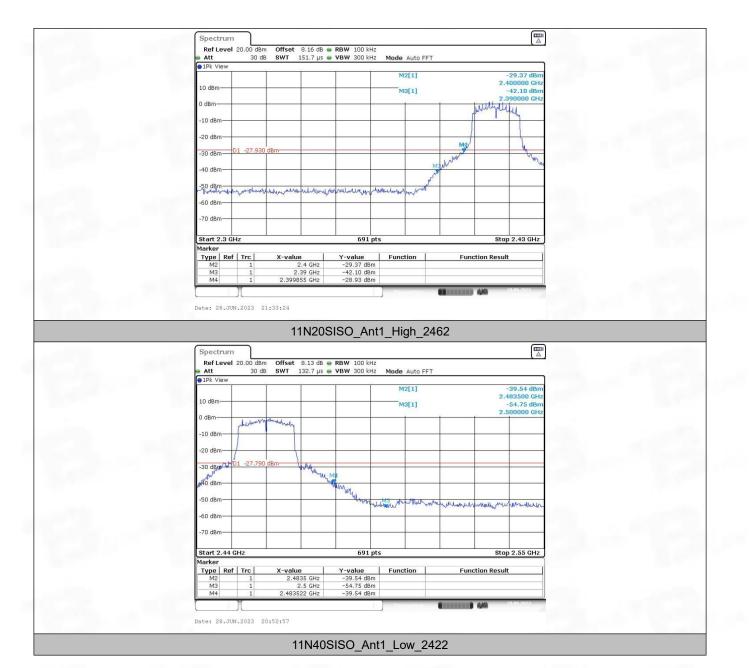






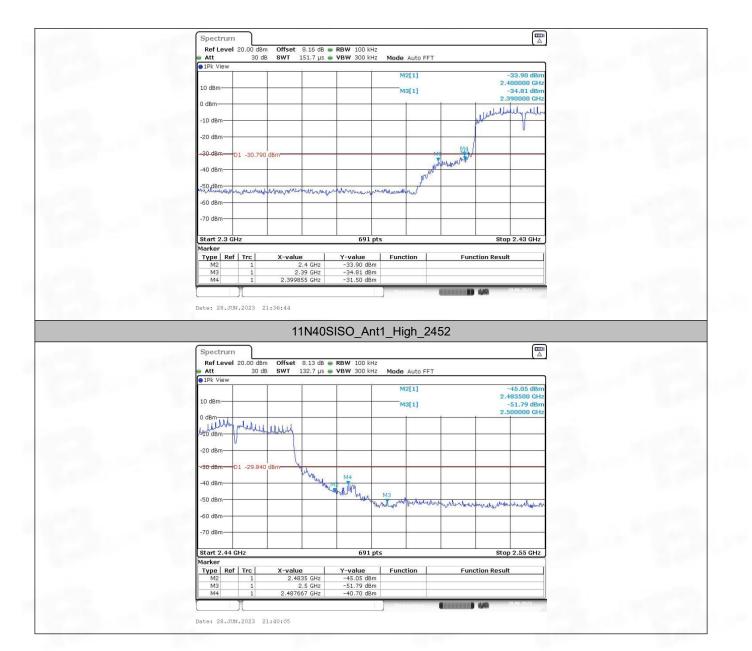
Page 90 of 94





Page 91 of 94





Page 92 of 94



Test Report Number: BTF230710R00304

6. Form731

6.1 Form731

6.1.1 Test Result

Lower Freq (MHz)	High Freq (MHz)	MAX Power (W)	MAX Power (dBm)
2412	2462	0.029992	14.77
2422	2452	0.020370	13.09



Test Report Number: BTF230710R00304



BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

www.btf-lab.com

-- END OF REPORT --

Total or partial reproduction of this document without permission of the Laboratory is not allowed.Page 94 of 94BTF Testing Lab (Shenzhen) Co., Ltd.F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China